

CORRECTION

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Correction: Enhanced field emission stability of vertically aligned carbon nanotubes through anchoring for X-ray imaging applications

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Correction for 'Enhanced field emission stability of vertically aligned carbon nanotubes through anchoring for X-ray imaging applications' by Xinchuan Liu et al., *J. Mater. Chem. C*, 2023, **11**, 2505–2513, <https://doi.org/10.1039/d2tc04363g>.

The authors wish to update the details of affiliation c given in the published article, as well as the address details given on the associated inside back cover, replacing "GBA Research Innovation Institute for Nanotechnology" with "The GBA National Institute for Nanotechnology Innovation". The corrected list of affiliations for this article is as shown here.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.

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